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torney's Docket No. 046361/265059

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re:

Nause, et al.

Confirmation No.: 9988

Appl. No.:

10/602,185

Group Art Unit: 1765

Filed:

June 23, 2003

Examiner:

For:

SEMI-INSULATING BULK ZINC OXIDE SINGLE CRYSTAL

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(c)

Sir:

Attached is a list of documents on form PTO-1449 together with copies of each identified document. It is requested that the Examiner consider these documents and officially make them of record in accordance with the provisions of 37 C.F.R. § 1.97 and Section 609 of the MPEP. By submitting the listed documents, Applicant in no way makes any admission as to the prior art status of the listed documents, but is instead submitting the listed documents for the sake of full disclosure.

This Information Disclosure Statement is submitted in accordance with 37 C.F.R. § 1.97(c), before final Office Action or Allowance, whichever is earlier. Accordingly, no fee is believed to be necessary with the filing of this paper. However, if a fee is deemed necessary in connection with filing this paper, the Commissioner is authorized to charge any additional fee, or credit any refund, to our Deposit Account No. 16-0605.

Respectfully submitted,

Jon J. Jurgovan

Registration No. 34,633

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In re: Nause, et al. Appl. No.: 10/602,185 Filed: June 23, 2003

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Examiner Initials*						e of Patentee or of Cited Document	Relevant Passages of	Pages, Columns, Lines, Where Relevant Passages of Relevant Figure Appear			
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(Respect 04/2003) INFORMATION DISCLOSURE					Filing Date First Named Inventor Group Art Unit		June 23, 2003 Nause 1765				
					Application Number		10/602,185				
	Superior for form 1440/DTO				Complete if Known						

		OTHER DOCUMENTS	
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	English Language Translation Attached
	1	Y. LIU, C.R. GORLA, S. LIANG, N. EMANETOGLU, Y. LU, H. SHEN, AND M. WRABACK, "Ultravoilet Detectors Based On Epitaxial ZnO Films Grown by MOCVD," Journal of Electronic Materials, Vol. 29, No. 1, 2000, May 11, 1999, pgs. 69-74, Adelphi, Maryland	
	2	M. JOSEPH, H. TABATA, H. SAEKI, K. UEDA, T. KAWAI, "Fabrication of the low-resistive p-type ZnO by codoping method," Physcia B 302-303 (2001) pgs. 140-148, Osaka, Japan	
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	4	V.A. NIKITENKO, "Luminescence and EPR of Zinc Oxide (Review)," Moscow Institute of Railway Engineers, Moscow, Russia, Vol. 57 Nos. 5-6 ppgs. 367-385, May 18, 1992.	

Examiner	Date	
Signature	Considered	

^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.